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| | | First Named Inventor | T. MARUYAMA |
| | | Group Art Unit | 2818 |
| | | Examiner Name | THINH T. NGUYEN |
| Sheet | 1 | of | 1 |
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NON PATENT LITERATURE DOCUMENTS

| Exam Inits | Cite No ¹ | Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published. | T ⁶ |
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| TN | | JONES, K. A., et al., "Accurately determining the composition and thickness of layers in a GaAs/InGaAs superlattice." Appl. Phys. 76 (3), August 1, 1994, Pages 1609-1616. | |
| TN | | MAIER, M., et al., "Composition analysis of molecular beam epitaxy grown In _y Ga _{1-y} As/GaAs/Al _x Ga _{1-x} As quantum wells by determination of film thickness." J. Appl. Phys. 73 (8), April 15, 1993, 0021-8979/93/083820-07, American Institute of Physics, Pages 3820-3826. | |
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| Examiner Signature | | Date Considered | 12/09/2004 |

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